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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/029,961	12/31/2001	Jai-young Kim	030681-349	5416
21839	7590 07/12/2005		EXAM	INER
	N INGERSOLL PC GBURNS, DOANE, SWEC	FALASCO, LOUIS V		
POST OFFICE BOX 1404 ALEXANDRIA, VA 22313-1404			ART UNIT	PAPER NUMBER
			1773	

DATE MAILED: 07/12/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

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*	Application No.	Applicant(s)
	10/029,961	KIM, JAI-YOUNG
Office Action Summary	Examiner	Art Unit
·	Louis Falasco	1773
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet w	with the correspondence address
A SHORTENED STATUTORY PERIOD FOR REPL' THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period of the period for reply within the set or extended period for reply will, by statute any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a y within the statutory minimum of th will apply and will expire SIX (6) MC , cause the application to become A	a reply be timely filed irty (30) days will be considered timely. INTHS from the mailing date of this communication. ABANDONED (35 U.S.C. § 133).
Status		
1) Responsive to communication(s) filed on 24 M	larch 2005.	
2a) ☐ This action is FINAL . 2b) ☑ This	action is non-final.	
3) Since this application is in condition for allowar	nce except for formal ma	tters, prosecution as to the merits is
closed in accordance with the practice under E	Ex parte Quayle, 1935 C.	D. 11, 453 O.G. 213.
Disposition of Claims		
4)⊠ Claim(s) <u>1 and 3-11</u> is/are pending in the appli	cation.	
4a) Of the above claim(s) is/are withdraw	wn from consideration.	
5) Claim(s) is/are allowed.		
6)⊠ Claim(s) <u>1 and 3-11</u> is/are rejected.		
7) Claim(s) is/are objected to.	a alaada a	
8) Claim(s) are subject to restriction and/o	r election requirement.	
Application Papers		
9)☐ The specification is objected to by the Examine		·
10)⊠ The drawing(s) filed on 31 December 2001 is/a		
Applicant may not request that any objection to the		
Replacement drawing sheet(s) including the correct		
11)☐ The oath or declaration is objected to by the Ex	raminer. Note the attache	ed Office Action or form PTO-152.
Priority under 35 U.S.C. § 119		
12) Acknowledgment is made of a claim for foreign	priority under 35 U.S.C.	§ 119(a)-(d) or (f).
a)⊠ All b)□ Some * c)□ None of:		
1.⊠ Certified copies of the priority documents		
2. Certified copies of the priority documents		
3. Copies of the certified copies of the prior		n received in this National Stage
application from the International Bureau * See the attached detailed Office action for a list		t received
See the attached detailed Office action for a list	or the certified copies no	i received.
Attach mant(a)		
Attachment(s) 1) Notice of References Cited (PTO-892)	4) Interview	Summary (PTO-413)

2) Notice of Draftsperson's Patent Drawing Review (PTO-948)
 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
 Paper No(s)/Mail Date 11/15/04&03/24/05.

Paper No(s)/Mail Date. _

6) Other: _

5) Notice of Informal Patent Application (PTO-152)

PAPERS RECEIVED

This application is acknowledged as a Request for Continued Examination.

The Information Disclosure Statements filed 11/15/04 & 03/24/05 are acknowledged.

CLAIMS

The claims are: 1, and 3 to 11. All claims are under consideration.

In view of the Information Disclosure Statement filed 03/24/05 and discovery of new art the allowance of all claims made in the Notice of Allowability mailed 11/02/04 has been vacated by the examiner.

DETAILED ACTION

Statuary basis

The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

Rejections

1. Claims 1, 3 to 5, 7 and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over **Hirotaka et al** (JA 11185237) and *Ullmann's Encyclopedia of Industrial Chemistry* "Magnetic Quantities and Their Measurement" taken with **Honda et al**

(Extremely High Linear Density Recording by Perpendicular Magnetization - IEEE Trans. On Magnetics vol. 32 No. 5 Sept. 1996 pgs 3804-3806).

Hirotaka et al teaches a perpendicular recording disk including an under layer between a substrate and perpendicular magnetic recording layer - see structure of Drawing 2 or 14 illustrating the convention of a perpendicular recording disc with an intermediate soft layer (layer 16 or 58 of Drawings 1, 2 or 14) and the magnetic perpendicular layer constituents (Detailed Description paragraph 13). The claims also require the perpendicular recording layer of the recording disk have a thickness in a range where the ratio of perpendicular coercivity to maximum perpendicular coercivity decreases with reduced thickness of the perpendicular recording layer. While the perpendicular recording layer range taught in Hirotaka et al is within the thickness range disclosed for occurrence of the result of thickness in a range where the ratio of perpendicular coercivity to maximum perpendicular coercivity decreases with reduced thickness in the claimed properties. Further, Hirotaka et al points out the anisotropy, which one of ordinary skill would appreciate gives rise to coercivity, as evident from Ullmann's Encyclopedia of Industrial Chemistry "Magnetic Quantities and Their Measurement" page 3 second paragraph, is dependent on the thickness of this layer - see Hirotaka et al 'EXAMPLE' paragraph [0018], this is also illustrated in Drawing 12 showing coercivity in perpendicular magnetic films of 20nm to 150 nm thickness corresponding to applicants preferred thickness for coercivity - to - maximum perpendicular coercivity decreasing with the thickness of the perpendicular recording layer, explained at Hirotaka et al

'EXAMPLE' paragraph [0031], though **Hirotaka et al** does not explicitly set forth that coercivity - to - maximum perpendicular coercivity decreases with reduced thickness. However, **Honda et al** shows the relationship of thickness to coercivity and as evident from the illustration of magnetic perpendicular recording layer thickness δ and it's variation with output Ep (recording density response) at Fig. 1 and Hc with Ep at Fig 2 graphical presentation recording density responses for thicknesses and the Fig. 4 thickness δ dependence on out put (Hc) included in applicants specific thickness range shows coercivity - to - maximum perpendicular coercivity decreases with reduced thickness this is further evident from Table I of **Honda et al** employing the ranger of thickness for this preferred by applicants - as in instant claim 10.

It would have been obvious to one having ordinary skill in the art at the time the invention was made to adopt the recording density responses for thicknesses range for coercivity - to - maximum perpendicular coercivity decreases with reduced thickness of Honda et al for the perpendicular recording layer in the recording media of Hirotaka et al for purpose of optimizing the thickness of the perpendicular layer. One skilled in the art would have been motivated to adopt the Honda et al teaching with the expectation of maximizing the performance of the media for high density recording (see Introduction page 3804 in Honda et al).

In considering the equation of claim 4, though the art does not have this equation as a relationship, the claiming of an unidentified characteristic that appears inherently present does not necessarily make a claim to that character patentable.

Where claimed and prior art products have been shown to be substantially identical in structure or composition and a case of prima facie obviousness has been established the burden of proof shifts to applicant to show prior art products do not necessarily nor inherently posses the characteristic of the claimed product - see <u>In re Best</u>, *562 F.2d 1252*, *1254*, *195 USPQ 430*, *433* (CCPA 1977).

2. Claims 4 and 8 to 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over **Hirotaka et al** and *Ullmann's Encyclopedia* with **Honda et al** IEEE Trans. On Magnetics as applied to claims 1, 3 to 5, 7 and 11 above, and further in view of **Suzuki** et al (US 6641934) or **Hikosaka et al** (US 5942342).

Hirotaka et al and *Ullmann's Encyclopedia* with Honda et al do not teach selection of the soft magnetic layer materials of these claims. However Suzuki et al teaches selection of the soft magnetic layer materials of these claims including a perpendicular magnetic recording disk having an under layer (item 40) an intermediate soft layer between the underlayer (item 30) and perpendicular recording layer (item 11). Suzuki et al spells out the thickness of the layers may be determined as desired and also disclosed within applicants range (col. 4 lns 27, 28 and materials of col. 4 lns 50, 51) and the soft magnetic layer and the perpendicular magnetic layer form closed magnetic loops is an property that the Suzuki et al encompasses, as they disclose the same structure materials and thickness as applicant.

Hikosaka et al teaches the teaches selection of the soft and perpendicular magnetic layer materials of these claims including a perpendicular magnetic recording disk having an under layer (col. 3 ln 4) an intermediate soft layer between the underlayer (Fig 5 upper soft magnetic layer 12) and perpendicular recording layer (item 1). While Hikosaka et al doesn't explicitly require a thickness in the range where the ratio of perpendicular coercivity - to - maximum perpendicular coercivity decreases with reduced thickness of the perpendicular magnetic recording layer nor that the soft magnetic layer and the perpendicular magnetic layer form closed magnetic loops Hikosaka et al spells out the thickness of the layers may be determined as desired and this thickness is disclosed within applicants range (col. 9 lns 53, col. 10 ln25, 26). The perpendicular coercivity - to - maximum perpendicular coercivity and the soft magnetic layer and the perpendicular magnetic layer form closed magnetic loops is merely an unidentified property taught by the primary references that the Hikosaka et al appears to encompass, since they disclose the same structure materials and thickness as applicant and compositions (col. 7 lns 5-8, 23 col. 9 lns 14, 15).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to adopt selection of the soft and perpendicular magnetic layer materials of these claims of **Suzuki et al** or **Hikosaka et al** in the recording media of the primary references for purpose of reducing noise improving the anisotropy of the media (**Suzuki et al** col. 2 lns 33-36 or **Hikosaka et al** col. 3 ln 65 – col. 4 ln 6). One

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skilled in the art would have been motivated to adopt Suzuki et al or Hikosaka et al with the expectation of improving the signal out put of the media.

REFERENCES

Translations included by the examiner with this action correspond to patent documents cited by applicants in their Information Disclosure Statement.

 A line has been drawn through the IDS Non-Patent document of "OFFICE ACTION" issued by JPO since this has <u>not</u> been received.

Suzuki et al (US 6641934) and **Hikosaka et al** (US 5942342) have omitted from the attached PTOL 892 form since both have been cited in a previous Office Action mailed 01/29/04.

CONCLUSION

The claims are 1 and 3 to 11.

- No claim has been allowed.
- Information Disclosure Statement has been received.

INQUIRES

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Louis Falasco, PhD whose telephone number is (571)272-1507. The examiner can normally be reached on M-F 10:30 - 7:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carol D. Chaney, PhD can be reached at (571)272-1284. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

ZF LF 04/05

> STEVAN A. RÉSAN PRIMARY EXAMINER